



**THE DATASHEET OF
DMC3025LSD-13**



30V COMPLEMENTARY ENHANCEMENT MODE MOSFET
Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} max	Package	I _D MAX T _A = +25°C
N-Channel	30V	20mΩ @ V _{GS} = 10V	SO-8	8.5A
		32mΩ @ V _{GS} = 4.5V		7.0A
P-Channel	-30V	45mΩ @ V _{GS} = -10V		-5.5A
		85mΩ @ V _{GS} = -4.5V		-4.1A

Description

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

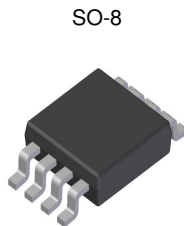
- DC Motor Control
- DC-AC Inverters

Features

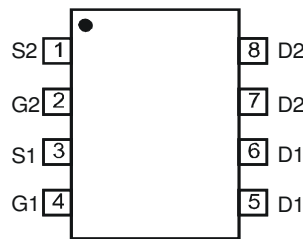
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**

Mechanical Data

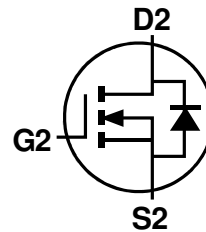
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish — Matte Tin Annealed Over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (e3)
- Weight: 0.008 grams (Approximate)



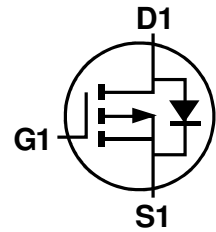
Top View



Pin Configuration



Q2 N-CHANNEL MOSFET



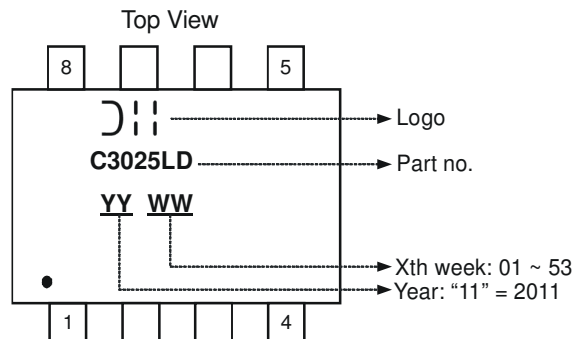
Q1 P-CHANNEL MOSFET

Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3025LSD-13	SO-8	2,500/Tape & Reel

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 4. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>

Marking Information


Maximum Ratings N-CHANNEL– Q2 (@T_A = +25 °C, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	30	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	T _A = +25°C T _A = +70°C	I _D	6.5 5.1	A
	t<10s	T _A = +25°C T _A = +70°C	I _D	8.5 6.8	A
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	T _A = +25°C T _A = +70°C	I _D	5.3 4.1	A
	t<10s	T _A = +25°C T _A = +70°C	I _D	7.0 5.5	A
Maximum Continuous Body Diode Forward Current (Note 5)			I _S	2	A
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	60	A
Pulsed Body Diode Current (10µs pulse, duty cycle = 1%)			I _{SM}	60	A
Avalanche Current (Note 7) L = 0.1mH			I _{AS}	14	A
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	10	mJ

Maximum Ratings P-CHANNEL– Q1 (@T_A = +25 °C, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	-30	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 5) V _{GS} = -10V	Steady State	T _A = +25°C T _A = +70°C	I _D	-4.2 -3.2	A
	t<10s	T _A = +25°C T _A = +70°C	I _D	-5.5 -4.3	A
Continuous Drain Current (Note 5) V _{GS} = -4.5V	Steady State	T _A = +25°C T _A = +70°C	I _D	-3.5 -2.3	A
	t<10s	T _A = +25°C T _A = +70°C	I _D	-4.1 -3.2	A
Maximum Continuous Body Diode Forward Current (Note 5)			I _S	-2	A
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	-30	A
Pulsed Body Diode Current (10µs pulse, duty cycle = 1%)			I _{SM}	-30	A
Avalanche Current (Note 7) L = 0.1mH			I _{AS}	-14	A
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	10	mJ

Thermal Characteristics

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 6)	T _A = +25°C	P _D	1.2	W
	T _A = +70°C		0.77	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	R _{θJA}	104	°C/W
	t<10s		62	
Total Power Dissipation (Note 5)	T _A = +25°C	P _D	1.5	W
	T _A = +70°C		0.95	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R _{θJA}	83	°C/W
	t<10s		49	
Thermal Resistance, Junction to Case (Note 5)		R _{θJC}	15	
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

Electrical Characteristics N-CHANNEL– Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	—	—	V	V _{GS} = 0V, I _D = 250μA
Zero Gate Voltage Drain Current	I _{DSS}	—	—	1	μA	V _{DS} = 30V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	—	—	±1	μA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	—	2.0	V	V _{DS} = V _{GS} , I _D = 250μA
Static Drain-Source On-Resistance	R _{DS(on)}	—	15	20	mΩ	V _{GS} = 10V, I _D = 7.4A
		—	23	32		V _{GS} = 4.5V, I _D = 6A
Forward Transfer Admittance	Y _{fs}	—	8	—	S	V _{DS} = 5V, I _D = 10A
Diode Forward Voltage	V _{SD}	—	0.70	1.2	V	V _{GS} = 0V, I _S = 1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	—	501	—	pF	V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	C _{oss}	—	72	—		
Reverse Transfer Capacitance	C _{rss}	—	57	—		
Gate Resistance	R _g	—	1.84	—	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Q _g	—	4.6	—	nC	V _{DS} = 15V, I _D = 10A
Total Gate Charge (V _{GS} = 10V)	Q _g	—	9.8	—		
Gate-Source Charge	Q _{gs}	—	1.6	—		
Gate-Drain Charge	Q _{gd}	—	2.0	—		
Turn-On Delay Time	t _{D(on)}	—	3.9	—	ns	V _{DD} = 15V, V _{GS} = 10V, R _G = 6Ω, I _D = 1A
Turn-On Rise Time	t _r	—	4.2	—		
Turn-Off Delay Time	t _{D(off)}	—	16.6	—		
Turn-Off Fall Time	t _f	—	5.8	—		
Reverse Recovery Time	t _{rr}	—	5.5	—	ns	I _F = 12A, di/dt = 500A/μs
Reverse Recovery Charge	Q _{rr}	—	2.6	—	nC	

Electrical Characteristics P-CHANNEL – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	—	—	V	V _{GS} = 0V, I _D = -250μA
Zero Gate Voltage Drain Current	I _{DSS}	—	—	-1	μA	V _{DS} = -30V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	—	—	±100	nA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	-1.0	—	-2.0	V	V _{DS} = V _{GS} , I _D = -250μA
Static Drain-Source On-Resistance	R _{DS(ON)}	—	38	45	mΩ	V _{GS} = -10V, I _D = -5.2A
		—	65	85		V _{GS} = -4.5V, I _D = -4A
Forward Transfer Admittance	Y _{fs}	—	5	—	S	V _{DS} = -5V, I _D = -5.2A
Diode Forward Voltage	V _{SD}	—	-0.7	-1.2	V	V _{GS} = 0V, I _S = -1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{ISS}	—	590	—	pF	V _{DS} = -25V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	C _{OSS}	—	69	—	pF	
Reverse Transfer Capacitance	C _{RSS}	—	53	—	pF	
Gate Resistance	R _G	—	11	—	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Q _G	—	5.1	—	nC	V _{DS} = -15V, I _D = -6A
Total Gate Charge (V _{GS} = 10V)	Q _G	—	10.5	—	nC	
Gate-Source Charge	Q _{GS}	—	1.8	—	nC	
Gate-Drain Charge	Q _{GD}	—	1.9	—	nC	
Turn-On Delay Time	t _{D(on)}	—	6.8	—	ns	V _{DD} = -15V, V _{GS} = -10V, R _G = 6Ω, I _D = -1A
Turn-On Rise Time	t _r	—	4.9	—	ns	
Turn-Off Delay Time	t _{D(off)}	—	28.4	—	ns	
Turn-Off Fall Time	t _f	—	12.4	—	ns	I _F = 12A, di/dt = 500A/μs
Reverse Recovery Time	t _{rr}	—	14	—	ns	
Reverse Recovery Charge	Q _{rr}	—	11	—	nC	

- Notes: 7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = +25°C.
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing.

N-CHANNEL

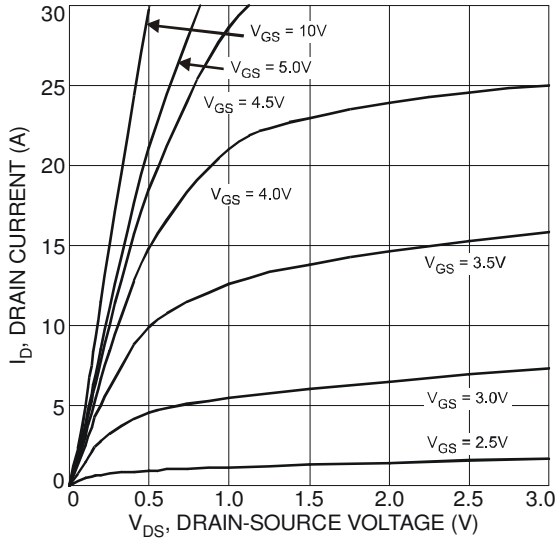


Figure 1. Typical Output Characteristic

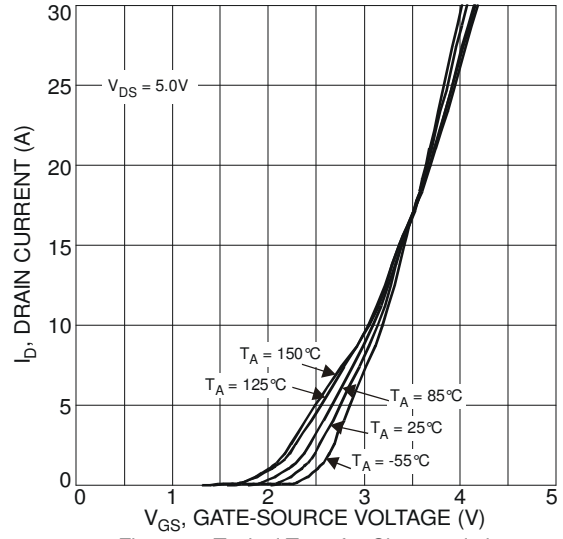


Figure 2. Typical Transfer Characteristics

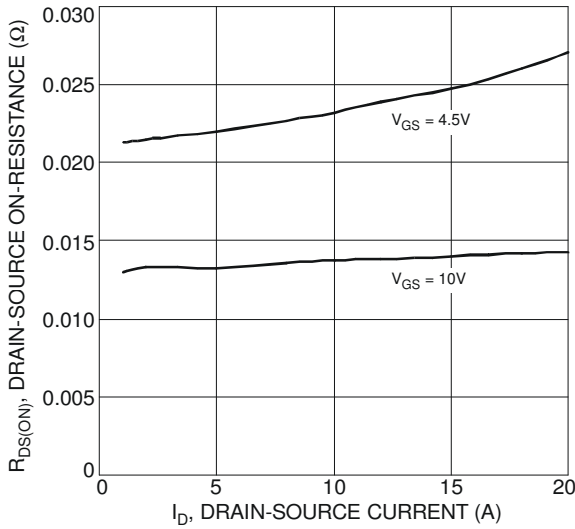


Figure 3 Typical On-Resistance vs. Drain Current and Gate Voltage

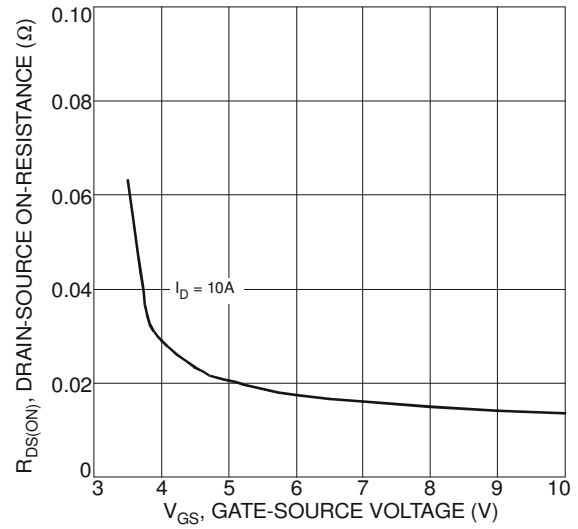


Figure 4. Typical On-Resistance vs. Drain Current and Gate Voltage

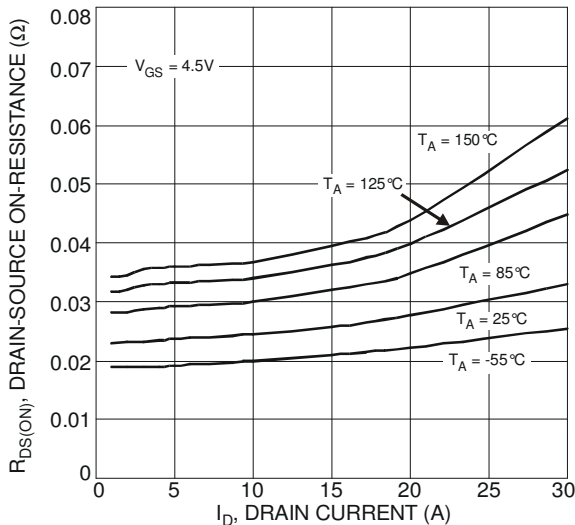


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

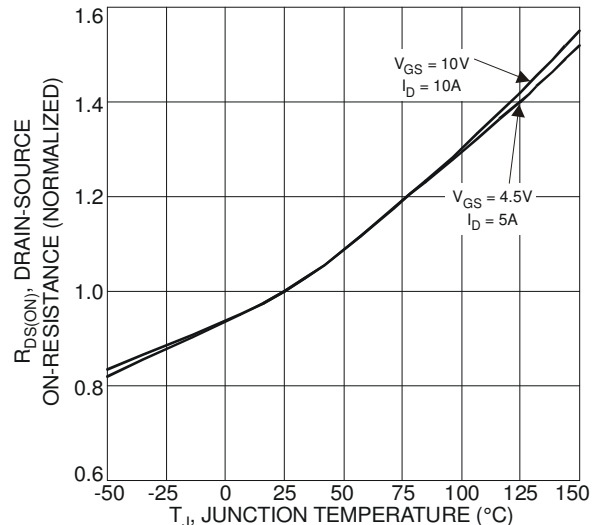


Figure 6. On-Resistance Variation with Temperature

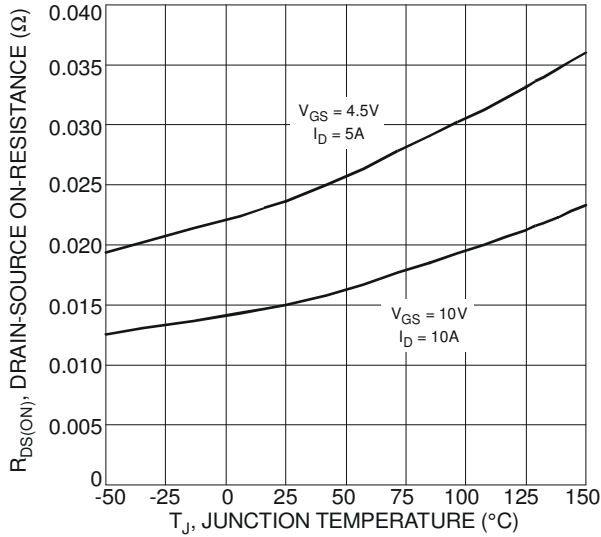


Figure 7. On-Resistance Variation with Temperature

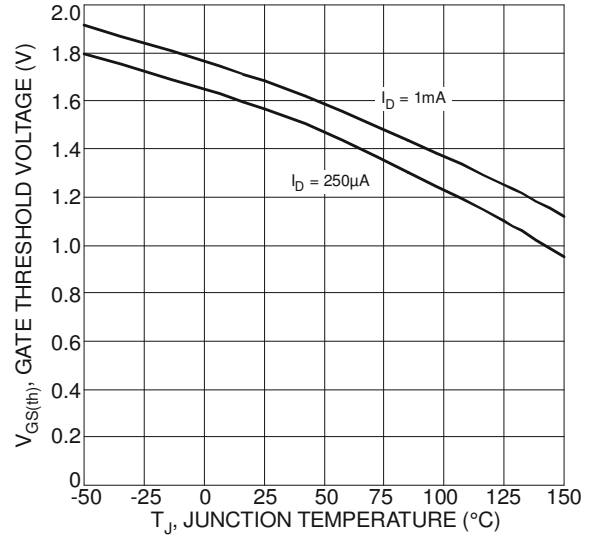


Figure 8 Gate Threshold Variation vs. Ambient Temperature

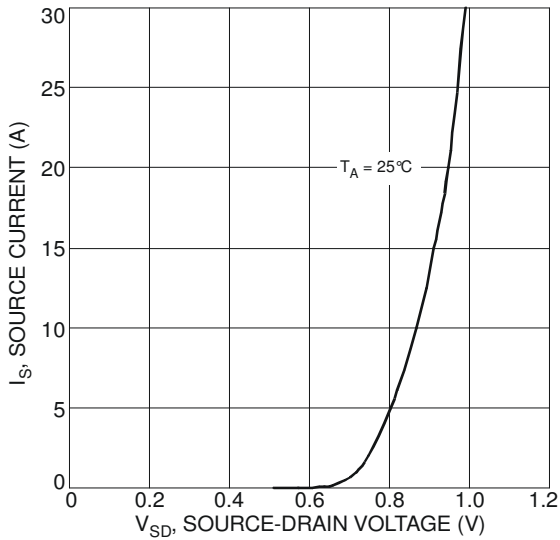


Figure 9. Diode Forward Voltage vs. Current

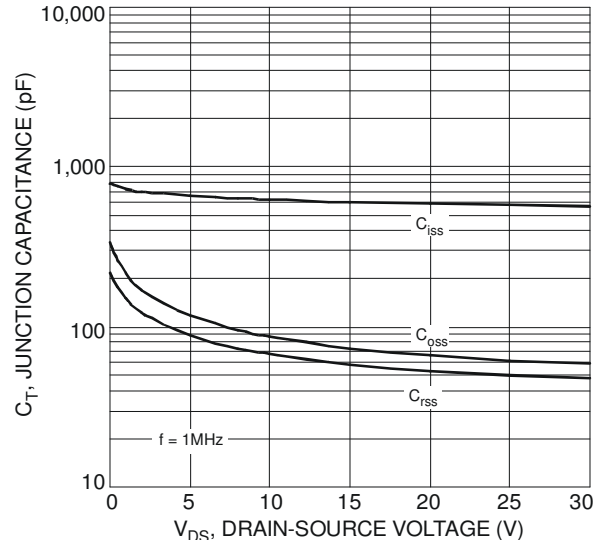


Figure 10. Typical Junction Capacitance

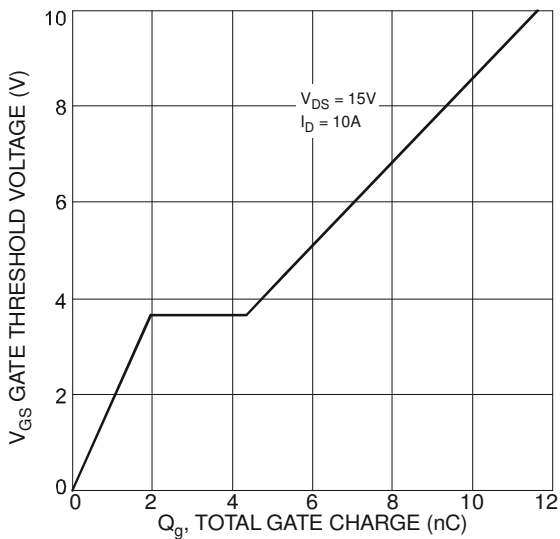


Figure 11. Gate Charge

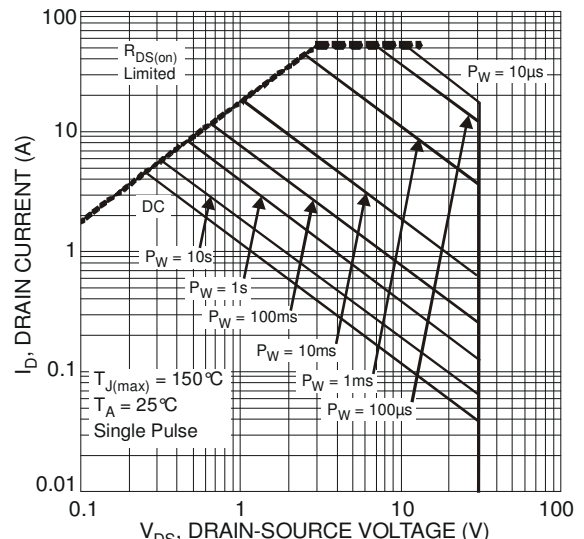


Figure 12. SOA, Safe Operation Area

P-CHANNEL

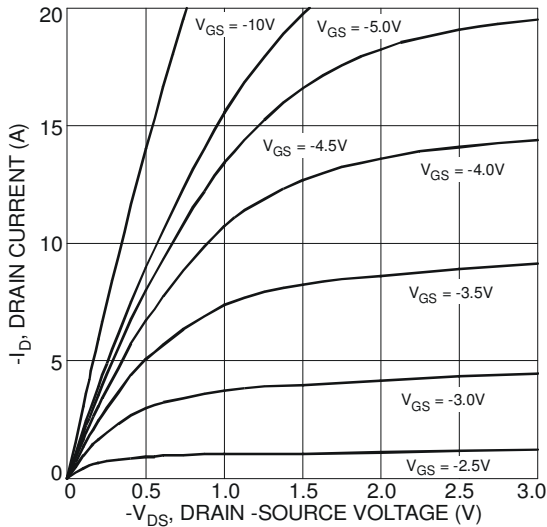


Figure 13. Typical Output Characteristics

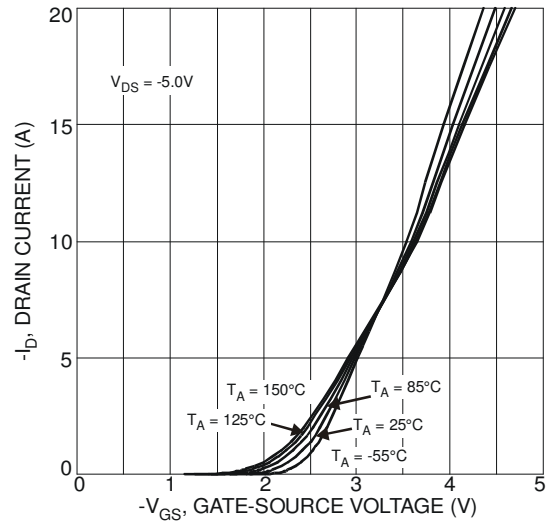


Figure 14. Typical Transfer Characteristics

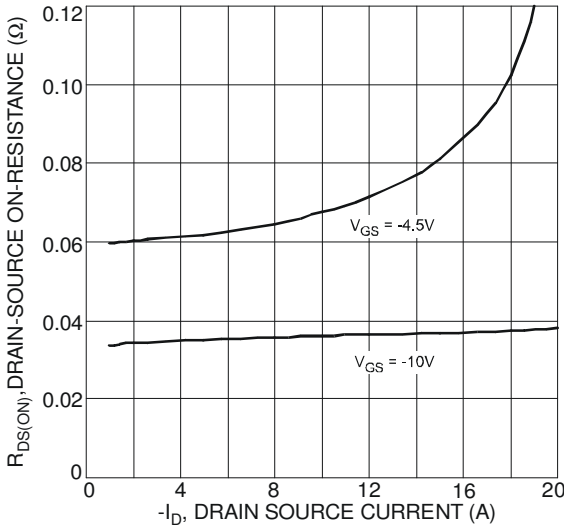


Figure 15. Typical On-Resistance vs. Drain Current and Gate Voltage

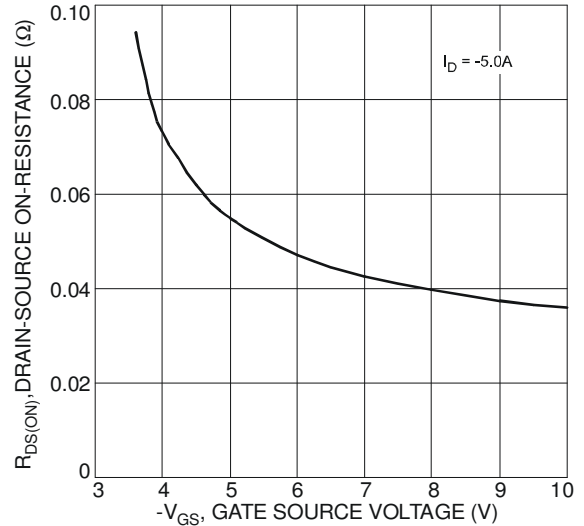


Figure 16. Typical On-Resistance vs. Drain Current and Gate Voltage

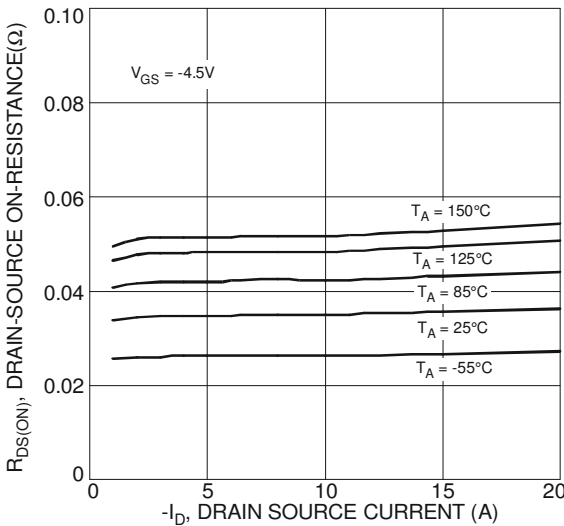


Figure 17. Typical On-Resistance vs. Drain Current and Temperature

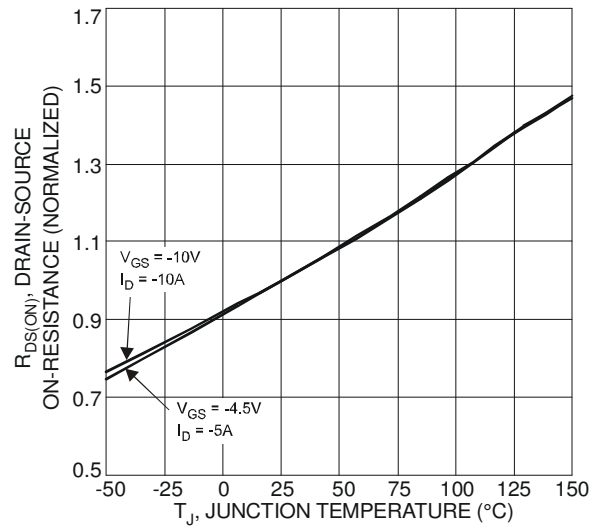


Figure 18. On-Resistance Variation with Temperature

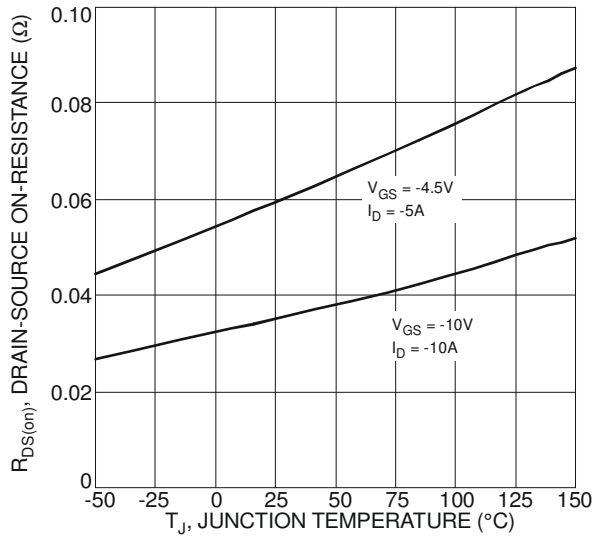


Figure 19. On-Resistance Variation with Temperature

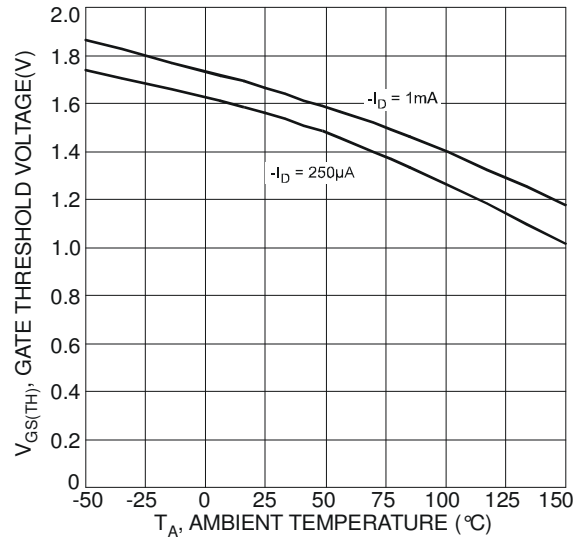


Figure 20. Gate Threshold Variation vs. Ambient Temperature

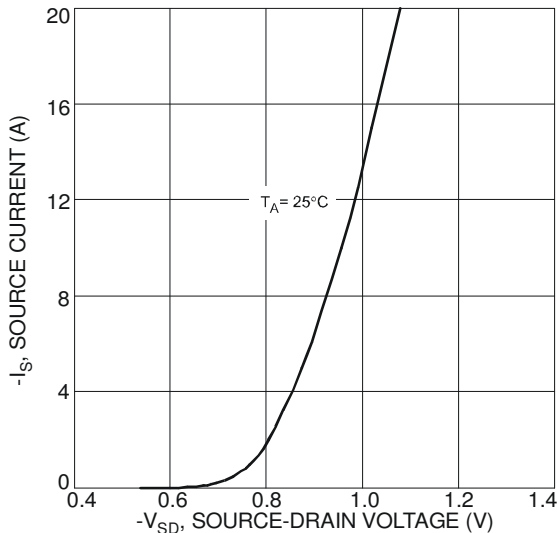


Figure 21. Diode Forward Voltage vs. Current

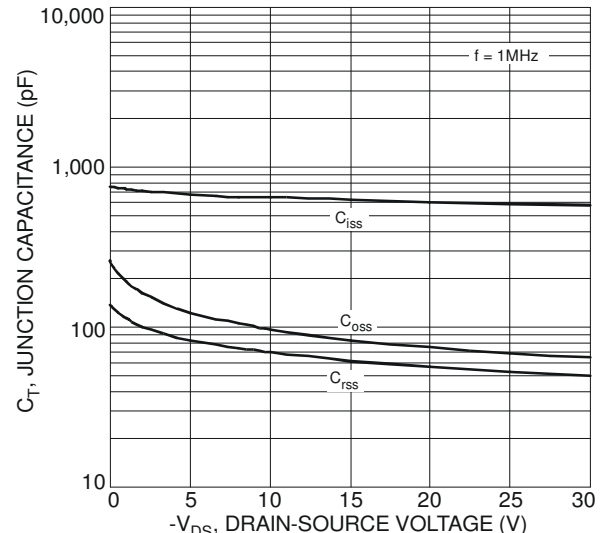


Figure 22. Typical Junction Capacitance

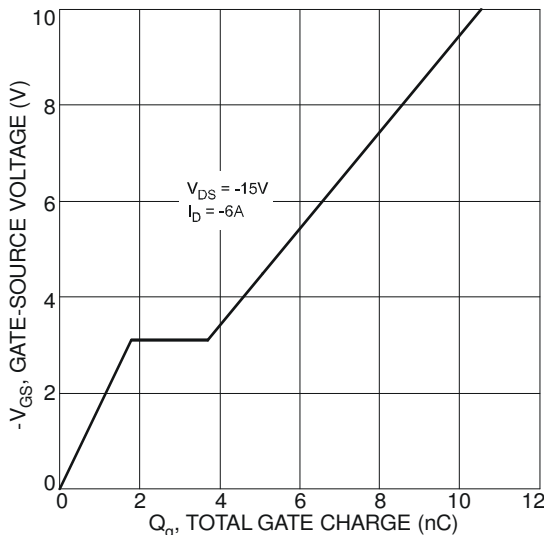


Figure 23. Gate-Charge Characteristics

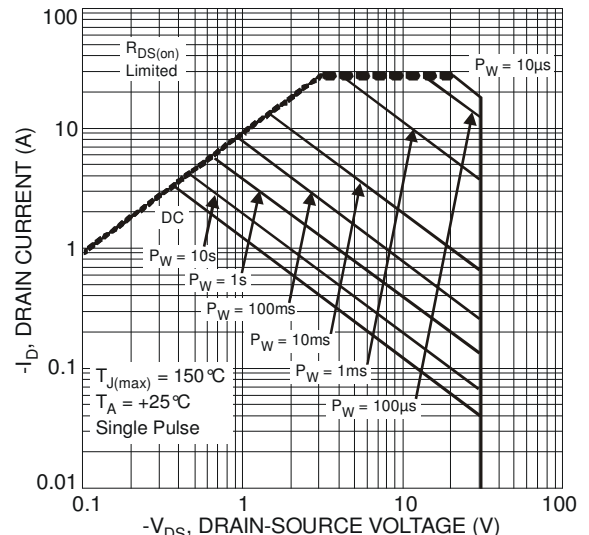
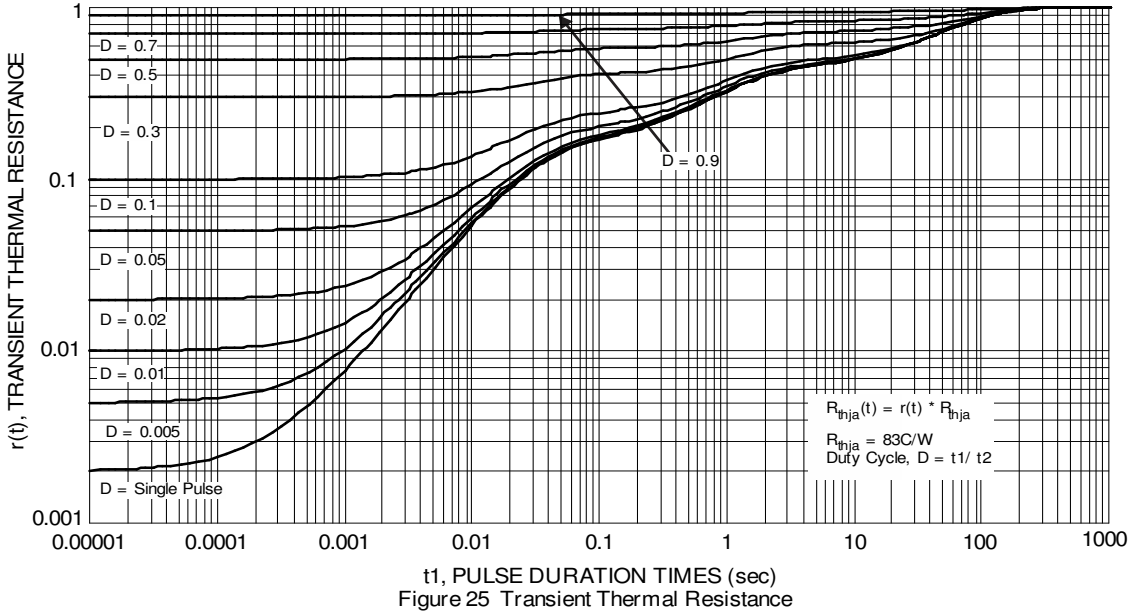
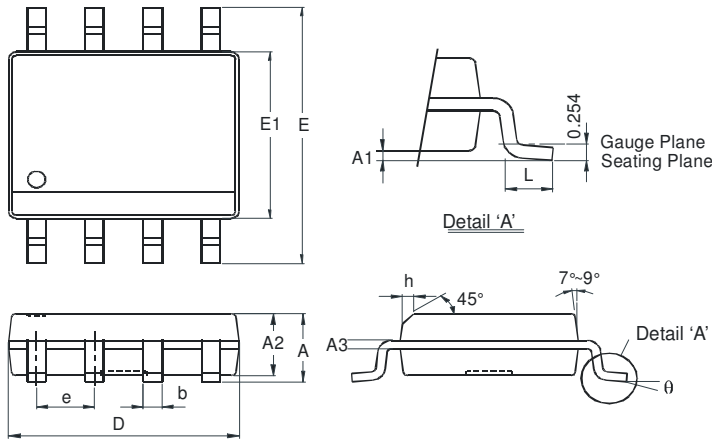


Figure 24. SOA, Safe Operation Area



Package Outline Dimensions

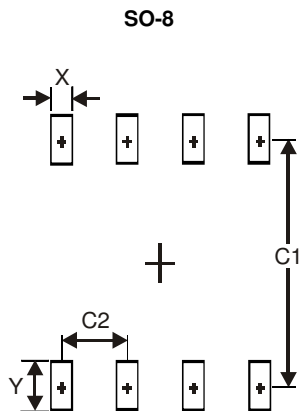
Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for the latest version.



SO-8		
Dim	Min	Max
A	-	1.75
A1	0.10	0.20
A2	1.30	1.50
A3	0.15	0.25
b	0.3	0.5
D	4.85	4.95
E	5.90	6.10
E1	3.85	3.95
e	1.27 Typ	
h	-	0.35
L	0.62	0.82
θ	0°	8°
All Dimensions in mm		

Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.



Dimensions	Value (in mm)
X	0.60
Y	1.55
C1	5.4
C2	1.27

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